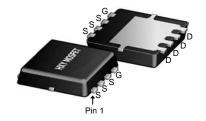


General Description

The NTMFS5C628NT1G use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics.

This device is specially designed to get better ruggedness.



DFN5X6-8L

General Features

V_{DS} =60V I_D =125A

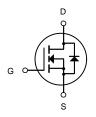
 $R_{DS(ON)}$ < 2.9m Ω @ V_{GS} =10V

Applications

Consumer electronic power supply Motor control

Synchronous-rectification Isolated DC

Synchronous-rectification applications



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
NTMFS5C628NT1G	DFN5X6-8L	HXY MOSFET	5000

Absolute Maximum Ratings (T_C =25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	60	V
Vgs	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V	Α	
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V 101		А
Ірм	Pulsed Drain Current ² 641		Α
EAS	Single Pulse Avalanche Energy ³	Single Pulse Avalanche Energy ³ 189	
P _D @T _C =25°C	Total Power Dissipation ⁴	113	W
Тѕтс	Storage Temperature Range	-55 to 150	
TJ	Operating Junction Temperature Range -55 to 150		°C
R _θ JC	Thermal Resistance from Junction-to-Ambient ³	Junction-to-Ambient ³ 1.11	
Reja	Thermal Resistance Junction-Ambient ¹	39.4	°C/W



Electrical Characteristics (T_J=25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V,	-	-	1.0	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±20V	-	-	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.2	1.6	2.2	V
R _{DS(on)}	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =20A	-	2.4	2.9	mΩ
C _{iss}	Input Capacitance	\/ 20\/\/ 0\/	-	4610	6915	pF
Coss	Output Capacitance	V _{DS} =30V,V _{GS} =0V, f=1.0MHz	-	2188	3282	pF
Crss	Reverse Transfer Capacitance	1-1.0101112	-	66	132	pF
Qg	Total Gate Charge	\/ -20\/ -40A	-	74.37	111.56	nC
Q _{gs}	Gate-Source Charge	V _{DS} =30V, I _D =40A, V _{GS} =10V	-	17.26	-	nC
Q _{gd}	Gate-Drain("Miller") Charge	VGS-10V	-	9.44	18.88	nC
t _{d(on)}	Turn-on Delay Time		-	14.13	-	ns
t _r	Turn-on Rise Time	V_{DD} =30 V , I_D =40 A ,	-	63.73	-	ns
t _{d(off)}	Turn-off Delay Time	$R_G=2.7\Omega, V_{GS}=10V$	-	46.8	-	ns
t f	Turn-off Fall Time		-	105.07	-	ns
Is	Maximum Continuous Drain to Source Diode Forward Current			-	125	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	641	Α
V _{SD}	Drain to Source Diode Forward	V _{GS} =0V, I _S =40A	-	-	1.2	V
VSD	Voltage	VGS-UV, IS-4UA				
t _{rr}	Body Diode Reverse Recovery Time	⊤	-	52.78	105.56	ns
Qrr	Body Diode Reverse Recovery Charge	I _F =40A,dI/dt=100A/μs	-	56.31	112.62	nC

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

- 2. EAS condition: $T_J = 25\,^{\circ}\mathrm{C}$, $V_{DD} = 30V$, $V_G = 10V$, $R_G = 25\Omega$, L = 0.5mH , $I_{AS} = 12A$
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



Typical Characteristics

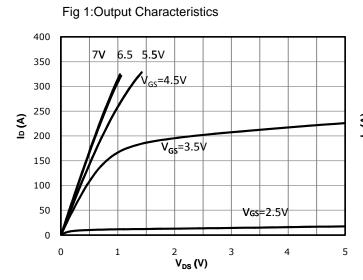


Fig 2:Transfer Characteristics

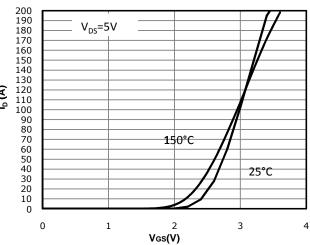


Fig 3: Rds(on) vs Drain Current and Gate Voltage

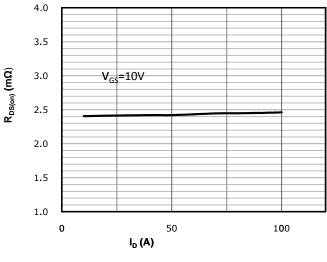


Fig 4: Rds(on) vs Gate Voltage

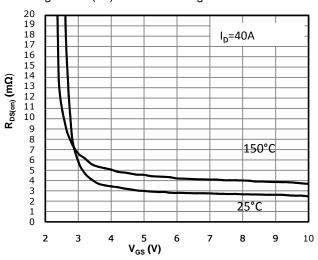


Fig 5: Rds(on) vs. Temperature

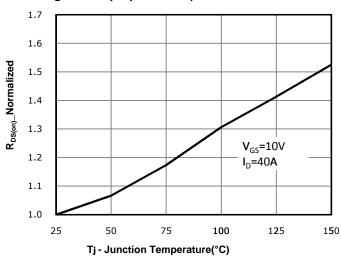
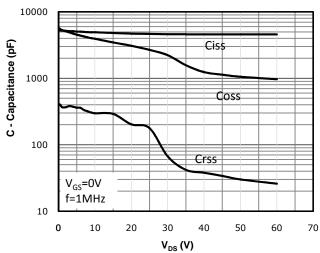
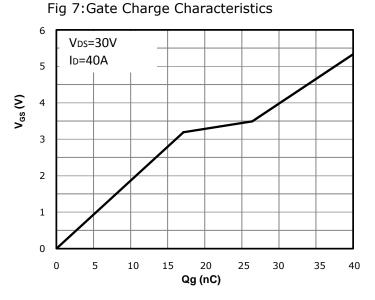


Fig 6: Capacitance Characteristics







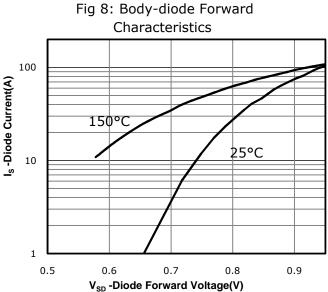
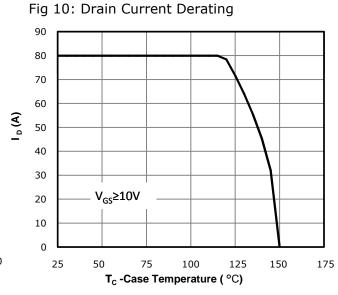
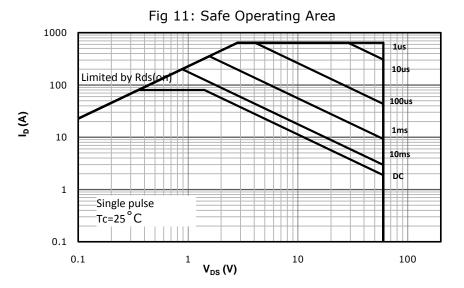
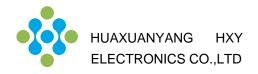
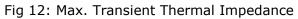


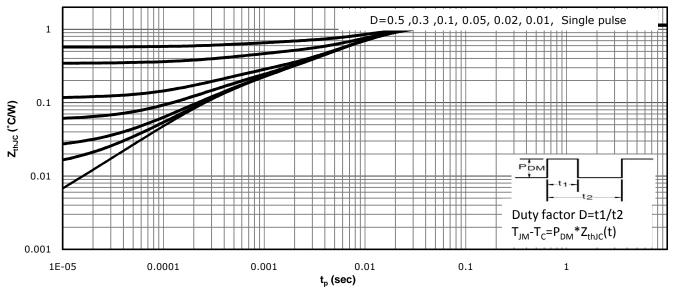
Fig 9: Power Dissipation T_{C} -Case Temperature (°C)



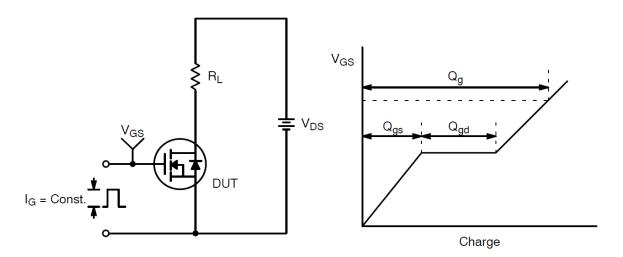




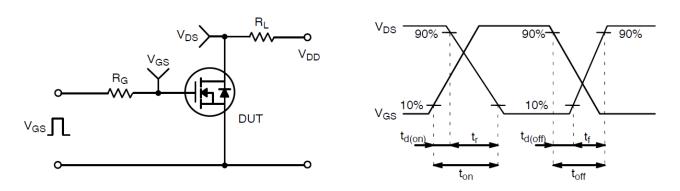




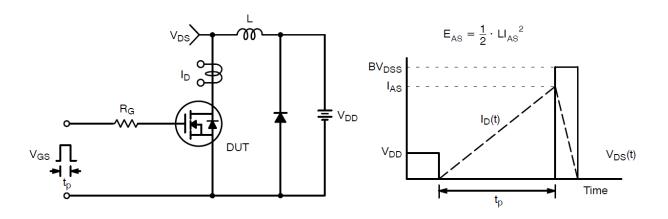
Test Circuit and Waveform:



Gate Charge Test Circuit & Waveform



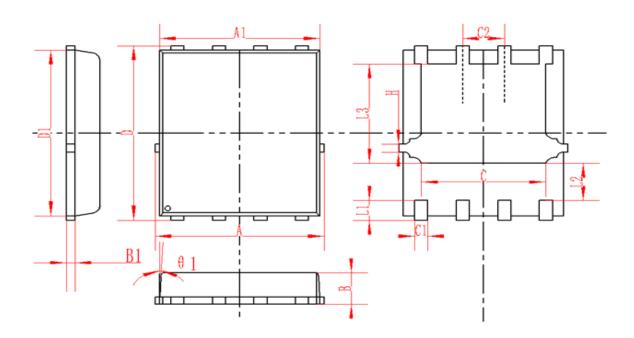
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



DFN5X6-8L Package Information



SYMBOL	MM		INCH			
	MIN	NOM	MAX	MIN	NOM	MAX
А	4.95	5	5.05	0.195	0.197	0.199
A1	4.82	4.9	4.98	0.190	0.193	0.196
D	5.98	6	6.02	0.235	0.236	0.237
D1	5.67	5.75	5.83	0.223	0.226	0.230
В	0.9	0.95	1	0.035	0.037	0.039
B1	0.254REF		0.010REF			
С	3.95	4	4.05	0.156	0.157	0.159
C1	0.35	0.4	0.45	0.014	0.016	0.018
C2	1.27TYP		0.5TYP			
θ1	8°	10°	12°	8°	10°	12°
L1	0.63	0.64	0.65	0.025	0.025	0.026
L2	1.2	1.3	1.4	0.047	0.051	0.055
L3	3.415	3.42	3.425	0.134	0.135	0.135
Н	0.24	0.25	0.26	0.009	0.010	0.010



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